Electron Microscopy Study of Zinc Silicate Coated Diatom Frustules

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We have developed a novel bioengineering paradigm to fabricate Mn²⁺-doped zinc silicate (Zn₂SiO₄:Mn) with controllable optoelectronic properties using diatom frustules as templates. The use of these templates makes the optoelectronic properties tunable and also preserves the diatom morphology [1]. In this report, we present the results of electron microscopy characterization of the bioengineered *Pinnularia*-Zn₂SiO₄:Mn. It is expected that a systematic investigation of correlations between the fabrication conditions and the formation of the *Pinnularia*-Zn₂SiO₄:Mn nanomaterials will lead to an understanding of the formation mechanism and to the eventual control of their optoelectronic properties.

Zinc silicate was formed by thermal annealing of zinc chloride chemically deposited on diatom frustules. The zinc chloride particles were deposited on the surface of diatom frustules by heating the frustules in aqueous ZnCl₂ solution activated by Mn²⁺(aq). TEM and SEM specimens were carefully prepared by dispersing the diatom-Zn₂SiO₄:Mn in methanol. A couple of drops were then placed onto a TEM grid or Al stub using a micropipette. Electron microscopy characterizations were performed by a Tecnai F-20 field emission HRTEM/STEM/EDX at 200 keV and a FEI Sirion FESEM at 30 keV.

Fig. 1a shows a girdle view TEM image of an intact diatom *Pinnularia sp.* frustule that is 35 µm long and about 13 µm wide. Its central area is slightly constricted. The zinc silicate coating of the frustules is not uniform (Fig. 2b). The coating was integrated into the diatom frustules in two fundamental ways. In some areas the frustules were coated as nanoparticles (Fig. 1b) and in other areas the frustules were coated as a thin film (Fig. 2a). Results suggest that the thin film coating is best achieved with a high concentration of the aqueous ZnCl₂ solution. The original morphology of the diatom *Pinnularia sp.* was preserved during the coating process as shown in Fig. 1b, 2a and 3b1. Unlike physical deposition technique which would block the pores after coating, this method does not cover the pores (areolae) of the diatom frustules (Fig. 1b, 2a and 3b1). Fig. 1c shows that the black nanoparticles are zinc silicate particles. The diffraction pattern shows that the structure of the coated frustules is polycrystalline (Fig. 2c). Fig. 3a depicts the surface morphology of an intact *Pinnularia sp.* frustule. A slightly deflected raphe end and parallel striae are clearly visible in the inset. EDX mapping and EDX nanoprobe analysis (Fig. 3b1-2 and Fig. 3c respectively) reveal that Zn is an integral part of the thin film coating. A study of the optoelectronic properties of the bioengineered diatom semiconductor materials is in progress.

References
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Fig. 1 (a) TEM image of diatom *Pinnularia sp.* (b) STEM image of diatom deposited with Zn. (c) EDX line spectrum obtained from (b) showing the distribution of Zn along line A.

Fig. 2 (a)-(b) HRTEM image showing lattice fringes of Zn$_2$SiO$_4$ thin film in the (001) plane. (c) Diffraction pattern of diatom frustule with Zn$_2$SiO$_4$ coating.

Fig. 3 (a) SEM image of diatom *Pinnularia sp* (Insert: Magnified distal end of the diatom). (3b1) STEM image of diatom with Zn$_2$SiO$_4$ coating (Rectangle shows mapped area). (3b2) EDX map of the surface of a diatom frustule in (3b1), showing distribution of Zn (White color shows presence of Zn). (3c) EDX spot spectrum showing the chemical composition of the diatom with Zn$_2$SiO$_4$ coating (Cu is an artifact of the TEM grid).